

SEMICONDUCTOR REVERSE RECOVERY TIME TESTER 半導体逆回復時間測定器

TRR-D2A

2A



- TRR-D2A has been designed to measure diode reverse recovery time (T_{rr}) with oscilloscope. I_F and I_R are variable to 2A.
- ダイオードの逆回復時間 (T_{rr}) をオシロスコープを用いて測定します。 I_F/I_R は 2A まで可変できます。

MODEL	TRR-D2A
MEASUREMENT RANGE	
I_F	+0.1A~+2.0A
I_R	-0.1A~-2.0A
MEASUREMENT RANGE(T_{rr})	15ns~99.9ns
DETECTION TIMING	10% (VARIABLE [可変可能])
BINNING AND INTERFACE	
PRE OPEN/SHORT	I_F ON : $V_F > 4V$...OPEN I_F ON : $V_F < 0.1V$...SHORT
BIN INDICATION	PASS, LOW, HIGH, OPEN, SHORT
EXTERNAL I/F	Handler-I/F STANDARD
EXT CONTROL I/F	IEEE-488 I/F STANDARD(GP-IB)
DIMENSIONS & WEIGHT	
MAIN UNIT	270(W)×435(D)×245(H)…11kg
HEAD BOX	140(W)×215(D)×92(H)…2kg

Measurement Waveform

